Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
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Benjamin E. Lanier

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Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
380	252	7/17/	M		
713	176	12/5	#		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Inventor name Scarch (PALM)	7/27/	BL		
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